

April 1988 Revised September 2000

# 74F109 Dual JK Positive Edge-Triggered Flip-Flop

#### **General Description**

The F109 consists of two high-speed, completely independent transition clocked  $J\overline{K}$  flip-flops. The clocking operation is independent of rise and fall times of the clock waveform. The  $J\overline{K}$  design allows operation as a D-type flip-flop (refer to F74 data sheet) by connecting the J and  $\overline{K}$  inputs.

Asynchronous Inputs:

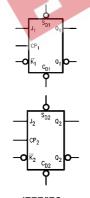
LOW input to  $\overline{S}_D$  sets Q to HIGH level LOW input to  $\overline{C}_D$  sets Q to LOW level Clear and Set are independent of clock Simultaneous LOW on  $\overline{C}_D$  and  $\overline{S}_D$  makes both Q and  $\overline{Q}$  HIGH

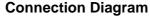
#### **Ordering Code:**

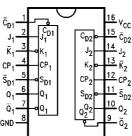
Order Number	Package Number	Package Description
74F109SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74F109SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F109PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

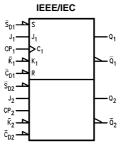
Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

#### **Logic Symbols**









#### **Truth Table**

Inputs					Out	puts
$\overline{s}_{D}$	$\overline{\mathbf{c}}_{D}$	CP	J	ĸ	Q	Q
L	Н	Χ	Χ	Х	Н	L
Н	L	Χ	Χ	Χ	L	Н
L	L	Χ	Χ	Χ	Н	Н
Н	Н	~	I	I	L	Н
Н	Н	~	h	I	Tog	ggle
Н	Н	~	I	h	Q	Q
Н	Н	~	h	h	Н	L
Н	Н	L	Х	Χ	Q	Q

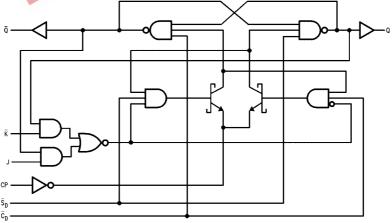
- $\begin{array}{c|c} & \Pi & \Pi \\ & H \ (h) = HIGH \ Voltage \ Level \\ & L \ (l) = LOW \ Voltage \ Level \\ & \swarrow = LOW \ to \ HIGH \ Transition \\ & X = Immaterial \\ & Q_0 \ \overline{(Q}_0) = Before \ LOW \ to \ HIGH \ Transition \ of \ Clock \end{array}$

Lower case letters indicate the state of the referenced output one setup time prior to the LOW-to-HIGH clock tra

### **Unit Loading/Fan Out**

	45 for		
Pin Names	<b>De</b> scrip <mark>tio</mark> n	U.L. HIGH/LOW	Input I <sub>IH</sub> /I <sub>IL</sub> Output I <sub>OH</sub> /I <sub>OL</sub>
$J_1, J_2, \overline{K}_1, \overline{K}_2$	Data Inputs	1.0/1.0	20 μA/-0.6 mA
CP <sub>1</sub> , CP <sub>2</sub>	Clock Pulse Inputs (Active Rising Edge)	1.0/1.0	20 μA/-0.6 mA
$\overline{C}_{D1}, \overline{C}_{D2}$	Direct Clear Inputs (Active LOW)	1.0/3.0	20 μA/–1.8 mA
$\overline{S}_{D1}, \overline{S}_{D2}$	Direct Set Inputs (Active LOW)	1.0/3.0	20 μA/–1.8 mA
$Q_1, Q_2, \overline{Q}_1, \overline{Q}_2$	Outputs	50/33.3	−1 mA/20 mA

## **Block Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## **Absolute Maximum Ratings**(Note 1)

-65°C to +150°C Storage Temperature

Ambient Temperature under Bias -55°C to +125°C Junction Temperature under Bias -55°C to +175°C

V<sub>CC</sub> Pin Potential to

Ground Pin -0.5V to +7.0V Input Voltage (Note 2) -0.5V to +7.0V -30 mA to +5.0 mA Input Current (Note 2)

Voltage Applied to Output

in HIGH State (with  $V_{cc} = 0V$ )

Standard Output

3-STATE Output -0.5V to +5.5V

Current Applied to Output

twice the rated  $I_{OL}$  (mA) in LOW State (Max)

#### **Recommended Operating Conditions**

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

## **DC Electrical Characteristics**

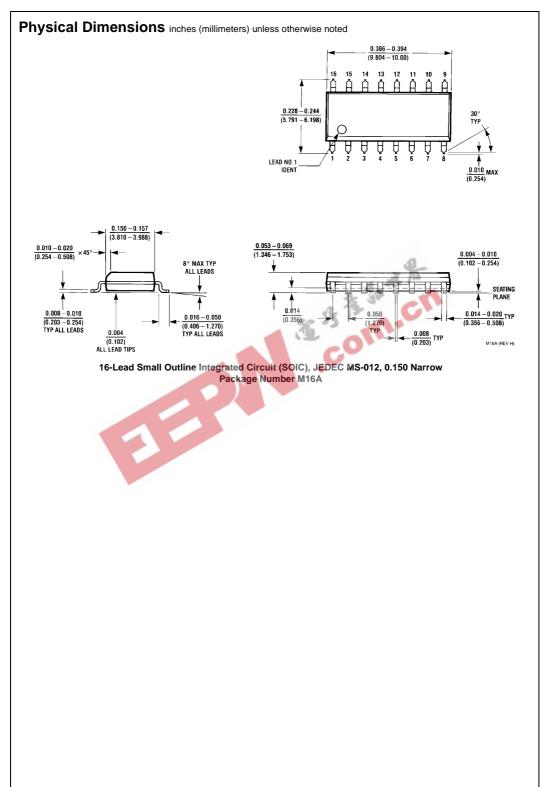
Symbol	Parameter	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage 10% V <sub>CC</sub>	2.5		1 30	C <sub>V</sub>	Min	I <sub>OH</sub> = -1 mA
	5% V <sub>CC</sub>	2.7			1		$I_{OH} = -1 \text{ mA}$
$V_{OL}$	Output LOW Voltage 10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 20 mA
I <sub>IH</sub>	Input HIGH Current			5.0	μΑ	Max	V <sub>IN</sub> = 2.7V
I <sub>BVI</sub>	Input HIGH Current Breakdown Test			7.0	μΑ	Max	V <sub>IN</sub> = 7.0V
I <sub>CEX</sub>	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC}$
V <sub>ID</sub>	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu\text{A}$
							All Other Pins Grounded
$I_{OD}$	Output Leakage			3.75	μА	0.0	$V_{IOD} = 150 \text{ mV}$
	Circuit Current			0.70	μι	0.0	All Other Pins Grounded
I <sub>IL</sub>	Input LOW Current			-0.6	mA	Max	$V_{IN} = 0.5V (J_n, \overline{K}_n)$
				-1.8	mA	Max	$V_{IN} = 0.5V (\overline{C}_{Dn}, \overline{S}_{Dn})$
los	Output Short-Circuit Current	-60		-150	mA	Max	V <sub>OUT</sub> = 0V
Icc	Power Supply Current		11.7	17.0	mA	Max	CP = 0V

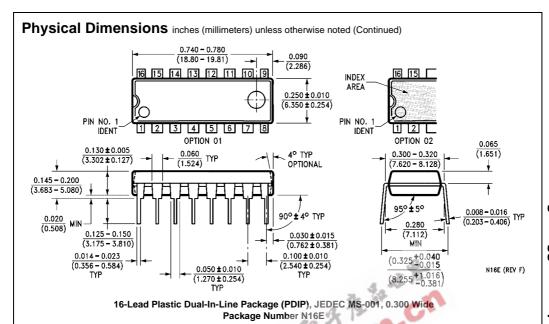
# AC Electrical Characteristics

Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50 \ pF$		Units
f <sub>MAX</sub>		Maximum Clock Frequency	100	125		90	
t <sub>PLH</sub>	Propagation Delay	3.8	5.3	7.0	3.8	8.0	
t <sub>PHL</sub>	$CP_n$ to $Q_n$ or $\overline{Q}_n$	4.4	6.2	8.0	4.4	9.2	ns
t <sub>PLH</sub>	Propagation Delay	3.2	5.2	7.0	3.2	8.0	ns
t <sub>PHL</sub>	$\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ to $Q_n$ or $\overline{Q}_n$	3.5	7.0	9.0	3.5	10.5	ns

# **AC Operating Requirements**

		<b>T</b> <sub>A</sub> =	+25°C	T <sub>A</sub> = 0°C	to +70°C	
Symbol	Symbol Parameter		$T_A = +25$ °C $V_{CC} = +5.0V$		V <sub>CC</sub> = +5.0V	
		Min	Max	Min	Max	
t <sub>S</sub> (H)	Setup Time, HIGH or LOW	3.0	7.0	3.0		
t <sub>S</sub> (L)	$J_n$ or $\overline{K}_n$ to $CP_n$	3.0	400	3.0		ns
t <sub>H</sub> (H)	Hold Time, HIGH or LOW	1.0		1.0		115
t <sub>H</sub> (L)	$J_n$ or $\overline{K}_n$ to $CP_n$	1.0		1.0		
t <sub>W</sub> (H)	CP <sub>n</sub> Pulse Width	4.0		4.0		ns
t <sub>W</sub> (L)	HIGH or LOW	5.0		5.0		115
t <sub>W</sub> (L)	$\overline{C}_Dn$ or $\overline{S}_Dn$ Pulse Width LOW	4.0		4.0		ns
t <sub>REC</sub>	Recovery Time $\overline{C}_{Dn}$ or $\overline{S}_{Dn}$ to CP	2.0		2.0		ns





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